

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Mok et al. Docket No.: NNEX0004

Serial No.: 10/069,902 Art Unit: 2815

Filed: February 20, 2002 Examiner: Clark, Jasmine

Title: SYSTEMS FOR TESTING AND PACKAGING INTEGRATED CIRCUITS

November 10, 2003

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

NOV 20 2003

This Information Disclosure Statement is submitted:

- () under 37 CFR 1.97(b), or
 (within three months of filing national application; or date of entry of international application; or before mailing date of first office action on the merits; whichever occurs last)
- (X) under 37 CFR 1.97(c) together with either a:
 - () Certification under 37 CFR 1.97(e), or
 - (X) a \$220.00 fee under 37 CFR 1.17(p), or (After the CFR 1.97(b) time period, but before final action or notice of allowance, whichever occurs first)
- () under 37 CFR 1.97(d) together with a:
 - () Certification under 37 CFR 1.97(e), and
 - () a \$220.00 fee under 37 CFR 1.17(d)(2)(ii), and
 - () a \$130.00 petition fee set forth in 37 CFR 1.17(i)(1)
 (Filed after final action or notice of allowance, whichever occurs first, but before payment of the issue fee)

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- (X) The Commissioner is authorized to charge any additional fees or credit any overpayment to Deposit Account No. 07-1445 (Order No. NNEX0004). A copy of this sheet is enclosed for accounting purposes.
- (X) Applicant(s) submit herewith Form PTO 1449 -- Information Disclosure Citation together with copies of patents, publications or other information of which applicant(s) are aware, which applicant(s) believe(s) may be material to the examination of this application and for which there may be a duty to disclose in accordance with 37 CFR 1.25.
- () A concise explanation of the relevance of foreign language patents, foreign language publications and other foreign language information listed on PTO Form 1449, as presently understood by the individual(s) designated in 37 CFR 156(c) most knowledgeable about the content is given on the attached sheet, or where a foreign language patent is cited in a search report or other action by a foreign patent office in a counterpart foreign application, an English language version of the search report or action which indicates the degree of relevance found by the foreign office is listed on form PTO 1449 and is enclosed herewith.

It is requested that the information disclosed herein be made of record in this application.

Respectfully Submitted,

Michael Glenn

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Informati n Discl sur Statem nt By Applicant Atty. Docket No.: NNEX0004

Serial No.: 10/069,902

Applicant: Mok et al.

Examiner: Clark, J.

Filing Date: Herewith

Group: 2815

U.S. Patent Documents

Examiner				l.		Sub-	Filing
Initial	No.	Patent No.	Date	Patentee	Class	class	Date
	Α	4,320,438	3/16/1982	Ibrahim, et al.	361	764	5/15/1980
	В	4,423,401	12/27/1983	Mueller	337	107	7/21/1982
	С	4,758,927	7/19/1988	Berg	361	761	.1/21/1987
	D	5,121,298	6/9/1992	Sarma, et al.	361	774	7/13/1990
	E	5,152,695	10/6/1992	Grabbe, et al.	439	71	10/10/1991
	F	5,166,774	11/24/1992	Benerji, et al.	361	749	10/5/1990
	G	5,280,139	1/18/1994	Suppelsa, et al.	174	260	8/17/1992
	Н	5,416,429	5/16/1995	McQuade, et al.	324	762	5/23/1994
		5,764,070	6/9/1998	Pedder	324	754	2/21/1996
	J	5,786,701	7/28/1998	Pedder	324	754	4/1/1996
	K	5,848,685	12/15/1998	Smith, et al.	200	275	12/20/1996
		5,864,946	2/2/1999	Eldridge, et al.	29	843	4/15/1997
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		Foreign Pa	tent or Public	hed Foreign Patent	Application	· ·	

Examiner		Document	Publication	Country or		Sub-	Trattis	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	MÐ
	М	96/41506	12/19/1996	WO :	H05K	1/14	X	20
	N	731369	5/3/1997	EPO	G02B	6/38	XF	03
	0	01/48870	7/5/2001	WO	H01R	13/24	XΝ	
							30	:
							- 0	

Other Documents

Examiner Initial	No.	Author, Titl	e, Date, Pla	ice (e.g. Journ	al) of Publ	ication	•	
, [†]		N/A						
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.